SPECIFICATION

SPEC. No.

D A T E : Sep., 2025

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Non-Controlled Copy

CUSTOMER'S PRODUCT NAME

TDK PRODUCT NAME

Multilayer Ceramic Chip Capacitors

Tape packaging [RoHS2 compliant]

C0402 type / C0G,X5R,X7R Characteristics

Please return this specification to TDK representatives. If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

RECEIPT CONFIRMATION

DATE: YEAR MONTH DAY

TDK Corporation

Sales

Engineering

Electronic Components
Sales & Marketing Group

Electronic Components Business Company Ceramic Capacitors Business Group

APPROVED	Person in charge

APPROVED	CHECKED	Person in charge

SCOPE

This delivery specification shall be applied to Multilayer ceramic chip capacitors to be delivered to

PRODUCTION PLACES

Production places defined in this specification shall be TDK Corporation, TDK(Suzhou)Co.,Ltd and TDK Components U.S.A.,Inc.

PRODUCT NAME

The name of the product to be defined in this specifications shall be $C0402\bigcirc\bigcirc\triangle\triangle\square\square\square$ ×.

REFERENCE STANDARD

JIS C 5101-1:2010	Fixed capacitors for use in electronic equipment-Part 1: Generic specification
C 5101-21:2014	Fixed capacitors for use in electronic equipment-Part 21 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class1
C 5101-22:2014	Fixed capacitors for use in electronic equipment-Part 22 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class2
C 0806-3:2014	Packaging of components for automatic handling - Part 3: Packaging of
	surface mount components on continuous tapes
JEITA RCR-2335 C 2014	Safety application guide for fixed ceramic capacitors for use in electronic
	equipment

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<EXPLANATORY NOTE>

When the mistrust in the spec arises, this specification is given priority. And it will be confirmed by written spec change after conference of both posts involved.

This specification warrants the quality of the ceramic chip capacitor. Capacitors should be evaluated or confirmed a state of mounted on your product.

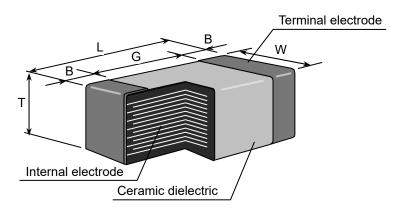
If the use of the capacitors goes beyond the bounds of this specification, we can not afford to guarantee.

Division	Date	SPEC. No.
Ceramic Capacitors Business Group	September, 2025	

1. CODE CONSTRUCTION

(Example) <u>C0402</u> <u>X5R</u> <u>1A</u> <u>102</u> <u>K</u> <u>T</u> <u>OOOO</u> (1) (2) (3) (4) (5) (6) (7)

(1) Case size



Туре	Dimensions (Unit : mm)				
TDK (EIA style)	L	W	Т	В	G
C0402 (CC01005)	0.40±0.02	0.20±0.02	0.20±0.02	0.07 min.	0.14 min.

^{*} As for each item, please refer to detail page on TDK web.

(2) Temperature Characteristics

* Details are shown in table 1 No.6 and 7 at 6.PERFORMANCE)

(3) Rated Voltage

Symbol	Rated Voltage
1 C	DC 16 V
1 A	DC 10 V

(4) Rated Capacitance

Stated in three digits and in units of pico farads (pF). The first and second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

(Example)

<u> </u>	
Symbol	Rated Capacitance
100	10 pF
102	1,000 pF

(5) Capacitance tolerance

Symbol	Tolerance	Capacitance	
D	±0.5 pF	10pF and under	
J	±5 %	Over 10pF	
K	±10 %	Over 10pF	

(6) Packaging

Symbol	Packaging
Т	Taping

(7) TDK internal code

2. COMBINATION OF RATED CAPACITANCE AND TOLERANCE

Class	Temperature Characteristics	Capacitance tolerance		Rated capacitance
		10pF and under	D (± 0.5pF)	10
1 C0G	Over 10pF	J (± 5%)	E – 3 series	
2	X5R X7R	K (± 10 %)		E – 3 series

Capacitance Step in E series

E series	Capacitance Step		
E- 3	1.0 2.2 4.7		4.7

3. OPERATING TEMPERATURE RANGE

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature
X5R	-55°C	85°C	25°C
C0G/X7R	-55°C	125°C	25°C

4. STORING CONDITION AND TERM

Storing temperature	Storing humidity	Storing term
5~40°C	20~70%RH	Within 6 months upon receipt.

5. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.

6. PERFORMANCE

table 1

			15.5.5				
No.	Itei	m	Performance	Те	st or inspection method		
1	External App	earance	No defects which may affect performance.	Inspect w	ith magnifying glass(10×)		
2	Insulation Resistance Voltage Proof		10,000MΩ or 100MΩ·μF min. whichever smaller.		g voltage : Rated voltage application time : 60s.		
3			Voltage Proof		Withstand test voltage without insulation breakdown or other damage.	Class 2 : 2 Voltage a	3 times of rated voltage 2.5 times of rated voltage pplication time : 1s. discharge current : 50mA or
4	Capacitance		Within the specified tolerance.	Please co represent	ontact with our sales ative.		
5	Q	Class1	Please refer to detail page on TDK web.	See No.4 condition.	in this table for measuring		
	Dissipation Factor	Class2					
6	Temperature Characteristics of Capacitance (Class1)		Temperature Coefficient (ppm/°C) COG : 0 ± 30 Capacitance drift Within ±0.2% or ±0.05pF, whichever larger.	calculated 85°C tem	ure Coefficient shall be I based on values at 25°C and perature. g temperature below 20°C 10°C and -25°C		
7	Temperature Characteristics of Capacitance (Class2)		Characteristics of Capacitance		Capacitance Change (%) No voltage applied X5R:±15 X7R:±15	steps sho thermal ed step.	nce shall be measured by the wn in the following table, after quilibrium is obtained for each culated ref. STEP3 reading.
				Step	Temperature(°C)		
				1	Reference temp. ± 2		
				2	Min. operating temp. ± 2		
				3	Reference temp. ± 2		
				Reference "3. OPERA As for me	Max. operating temp. ± 2 n./Max operating temp and te temp., please refer to ATING TEMPERATURE RANGE" teasuring voltage, please with our sales representative.		

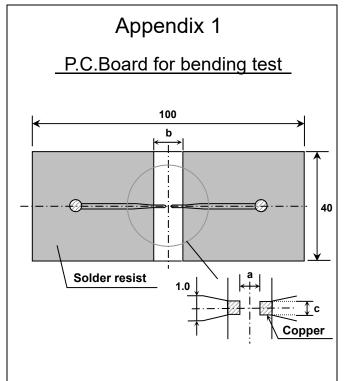
(cc	ntinued)		1			
No.	Ite	em		Per	formance	Test or inspection method
8	Bending		No mecha	nical	damage.	Reflow solder the capacitor on a P.C. Board shown in Appendix1 and bend it for 1mm. The state of the capacitor on a P.C. The state of the capaci
9	9 Solderability		areas shall be covered with a smooth and bright solder coating with no more than a small amount of scattered imperfections such as pinholes or un-wetted or de-wetted areas. These imperfections shall not be concentrated in one area.		overed with a ght solder coating an a small amount of fections such as vetted or de-wetted tions shall not be	Solder: Sn-3.0Ag-0.5Cu Flux: Isopropyl alcohol(JIS K 8839) Rosin(JIS K 5902) 25% solid solution. Preheating condition Temp.: 110 ~ 140°C Time: 30 ~ 60s.
						Reflow profile $ \begin{array}{c} 245 \\ O \\ O$
10	Resistance to solder heat	External appearance Capacitance	termination	ns sha	llowed and all be covered at new solder.	Solder : Sn-3.0Ag-0.5Cu Flux : Isopropyl alcohol(JIS K 8839) Rosin(JIS K 5902) 25% solid solution.
				C0G	Change from the value before test 2.5% or ±0.25pF max. whichever larger	Preheating condition Temp.: 110 ~ 140°C Time: 30 ~ 60s.
				X5R X7R	±7.5 %	Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement.
		Q (Class1)	Meet the initial spec.		spec.	Reflow profile
		D.F. (Class2)	Meet the in	Meet the initial spec.		260 Ω ΔT≦150
		Insulation Resistance	Meet the in			Ω ΔT≦150 ΔT ≤ 150
		Voltage proof	No insulati damage.	ion br	eakdown or other	0

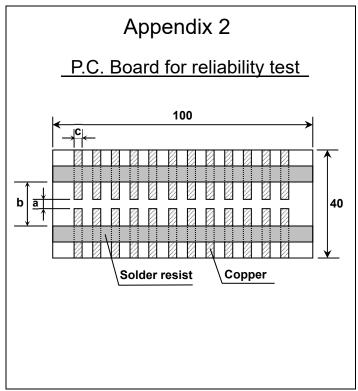
No.	Ite	em	Performance		Test or inspection method				
11	Vibration	External appearance	No mechanical damage.			Frequency: 10~55~10Hz Reciprocating sweep time: 1 min. Amplitude: 1.5mm			
		Capacitance			Change from the	Repeat	this for 2h each in 3		
			Characte	eristics	value before test	perpend	dicular directions(Tot	al 6h).	
			Class1	C0G	2.5% or ±0.25pF max. whichever larger		solder the capacitors ard shown in Append		
			Class2	X5R X7R	±7.5 %	testing.			
		Q (Class1)	Meet the	initial	spec.				
		D.F. (Class2)	Meet the	initial	spec.				
12	12 Temperature cycle	External appearance	No mechanical damage.		Expose the capacitors in the condition step1 through step 4 listed in the following table.				
		Capacitance	Characteristics Change from the		Temp. c	Temp. cycle : 5 cycles			
			Class 2 X5R representative	value before test	Step	Temperature(°C)	Time (min.)		
				with our sales	1 Min. operating temp.±3	30 ± 3			
				X7R		2	Ambient Temp.	2 ~ 5	
		Q (Class1)	Meet the	initial	spec.	3	Max. operating temp.±2	30 ± 2	
		D.F. (Class2)	Meet the	initial	spec.	4	Ambient Temp.	2 ~ 5	
		Insulation Resistance Voltage proof	Meet the initial spec. No insulation breakdown or other damage.		As for Min./Max. operating temp., please refer to "3. OPERATING TEMPERATURE RANGE"				
					Leave the capacitors in ambient condition for Class 1 : 6~24h Class 2 : 24±2h before measurement.				
							solder the capacitors ard shown in Append		

No.	It	em	Perfor	mance	Test or inspection method	
13	Moisture Resistance	External appearance	No mechanical damage.		Test temp.: 40±2°C Test humidity: 90~95%RH	
	(Steady state)	Capacitance	Characteristics	Change from the value before test	Test time: 500 +24,0h Leave the capacitors in ambient condition for	
			Y5R W	vith our sales epresentative.	Class 1 : 6~24h Class 2 : 24±2h before measurement.	
		Q			Reflow solder the capacitors on a P.C.Board shown in Appendix2 before	
		(Class1)	Capacitance	Q	testing.	
		,	30pF and over	350 min.	toomig.	
			10pF and over under 30pF	275+5/2×C min.		
			Under 10pF	200+10×C min.		
			C : Rated capa	citance (pF)		
		D.F. (Class2)	200% of initial spec max.			
		Insulation Resistance	1,000MΩ or 10MΩ whichever smalle	•		
14	Moisture Resistance	External appearance	No mechanical da	amage.	Test temp.: 40±2°C Test humidity: 90~95%RH Applied voltage: Betad voltage	
		Capacitance		Change from the value before test	Applied voltage : Rated voltage Test time : 500 +24,0h Charge/discharge current : 50mA or lower	
			Y5P W	lease contact vith our sales epresentative.	Leave the capacitors in ambient condition for Class 1 : 6~24h Class 2 : 24±2h before measurement.	
					Reflow solder the capacitors on a	
		Q (Class1)	Capacitance	Q	P.C.Board shown in Appendix2 before	
		(Class I)	30pF and over	200 min.	testing.	
			Under 30pF	100+10/3×C min.	Initial value setting (only for class 2)	
			C : Rated capacitance (pF)		Voltage conditioning 《After voltage trea	
		D.F. (Class2)	200% of initial spe	ec max.	 the capacitors under testing temperature and voltage for 1 hour, leave the capacitors in ambient condition for 24±2h 	
		Insulation Resistance	500MΩ or 5MΩ·μ whichever smalle		before measurement. Use this measurement for initial value.	

No.	Item			Perf	ormance	Test or inspection method		
15	appea	External appearance	No mechanical damage.			Test temp. : Maximum operating temperature±2°C Applied voltage : Please contact with our		
		Capacitance Cha		Characteristics Change from the value before test		sales representative. Test time: 1,000 +48,0h		
			Class1	C0G	Please refer to the table A in	Charge/discharge current : 50mA or lower		
			Class 2 X5R the	the end of the specification.	Leave the capacitors in ambient condition for Class 1 : 6~24h			
					Class 2 : 24±2h before measurement.			
		Q (Class1)	Capad	citance	Q	Reflow solder the capacitors on a P.C.Board shown in Appendix2 before		
			(Glass 1)	30pF a	nd over	350 min.	testing.	
				nd over r 30pF	275+5/2×C min.	Initial value setting (only for class 2)		
			Unde	r 10pF	200+10×C min.	Voltage conditioning 《After voltage trea		
			C : Rated capacitance (pF)		acitance (pF)	the capacitors under testing temperature and voltage for 1 hour, leave the		
		D.F. (Class2)	200% of	initial s	pec max.	capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.		
		Insulation Resistance		1,000MΩ or 10MΩ·μF min. whichever smaller.				

^{*}As for the initial measurement of capacitors (Class2) on number 7,10,11,12 and 13 leave capacitors at 150 -10,0°C for 1h and measure the value after leaving capacitors for 24±2h in ambient condition.

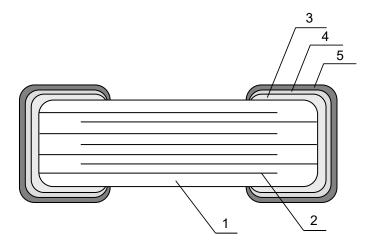




		(\	Jnit : mm)
Symbol Case size	а	b	С
C0402 (CC01005)	0.2	0.8	0.2

1. Material : Glass Epoxy(As per JIS C6484 GE4)

7. INSIDE STRUCTURE AND MATERIAL



No.	NAME	MATERIAL		
INO.	NAIVIE	Class1	Class2	
1	Dielectric	CaZrO ₃	BaTiO₃	
2	Electrode	Nicke	el (Ni)	
3		Сорре	er (Cu)	
4	Termination	Nickel (Ni)		
5		Tin (Sn)		

8. PACKAGING

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

Tape packaging is as per 11. TAPE PACKAGING SPECIFICATION.

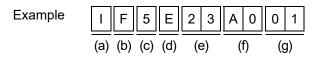
- 1) Inspection No.*
- 2) TDK P/N
- 3) Customer's P/N
- 4) Quantity

*Composition of Inspection No.

Example
$$\underline{F}$$
 $\underline{5}$ \underline{A} $\underline{23}$ $\underline{001}$ (a) (b) (c) (d) (e)

- (a) Line code
- (b) Last digit of the year
- (c) Month and A for January and B for February and so on. (Skip I)
- (d) Inspection Date of the month.
- (e) Serial No. of the day

^{*}Composition of new Inspection No. (Implemented on and after May 1, 2019 in sequence)



- (a) Prefix
- (b) Line code
- (c) Last digit of the year
- (d) Month and A for January and B for February and so on. (Skip I)
- (e) Inspection Date of the month.
- (f) Serial No. of the day(00 ~ ZZ)
- (g) Suffix($00 \sim ZZ$)

9. SOLDERING CONDITION

Reflow soldering only.

^{*} It was shifted to the new inspection No. on and after May 2019, but the implementation timing may be different depending on shipment bases. Until the shift is completed, either current or new composition of inspection No. will be applied.

10. CAUTION

No.	Process	Condition
1	Operating Condition (Storage, Use,	1-1. Storage, Use The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. JIS C 60721-3-1 Class 1K2 should be followed for the other climatic conditions.
	Transportation)	1) High temperature and humidity environment may affect a capacitor's solder ability because it accelerates terminal oxidization. They also deteriorate performance of taping and packaging. Therefore, SMD capacitors shall be used within 6 months. For capacitors with terminal electrodes consisting of silver or silver-palladium which tend to become oxidized or sulfurized, use as soon as possible, such as within one month after opening the bag.
		 When capacitors are stored for a longer time period than 6 months, confirm the solderability of the capacitors prior to use. During storage, keep the minimum packaging unit in its original packaging without opening it. Do not deviate from the above temperature and humidity conditions even for a short term.
		3) Corrosive gasses in the air or atmosphere may result in deterioration of the reliability, such as poor solderability of the terminal electrodes. Do not store capacitors where they will be exposed to corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine ammonia etc.)
		4) Solderability and electrical performance may deteriorate due to photochemical change in the terminal electrode if stored in direct sunlight, or due to condensation from rapid changes in humidity. The capacitors especially which use resin material must be operated and stored in an environment free of dew condensation, as moisture absorption due to condensation may affect the performance.
		5) Refer to JIS C 60721-3-1, class 1K2 for other climate conditions.
		1-2. Handling in transportation In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335C 9.2 Handling in transportation)
2	Circuit design	2-1. Operating temperature 1) Upper category temperature (maximum operating temperature) is specified. It is necessary to select a capacitor whose rated temperature us higher than the operating temperature. Also, it is necessary to consider the temperature distribution in the equipment and seasonal temperature variation.
		2) Surface temperature including self heating should be below maximum operating
		temperature. Due to dielectric loss, capacitors will heat itself when AC is applied due to ESR. Especially at high frequencies, please be careful that the heat might be so extreme.
		Also, even if the surface temperature of the capacitor includes self-heating and is the maximum operating temperature or lower, excessive heating of the capacitor due to self-heating may cause deterioration of the characteristics and reliability of the capacitor.
		The self-heating temperature rise of the capacitor changes depending on the difference in heat radiation due to the mounting method to the device, the ambient temperature, the cooling method of the device and circuit board material and the design, etc.
		The load should be contained so that the self-heating temperature rise of the capacitor body in a natural convection environment at an ambient temperature of 25°C remain below 20°C. When using in a high-frequency circuit or a circuit in which a capacitor generates heat, such as when a high-frequency ripple current flows, pay attention to the above precautions. (Note that accurate measurement may not be possible with self-heating measurement when the equipment applies cooling other than natural convection such as a cooling fan.)
		The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration.

No.	Process	Condition				
2	Circuit design	2-2. When overvoltage is applied				
	<u>∕!</u> Caution	Applying overvoltage to a capacitor may cause dielectric breakdown and result in a short circuit. The duration until dielectric breakdown depends on the applied voltage and the ambient temperature.				
		2-3. Operating voltage 1) Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V0-P must be below the rated voltage. — (1) and (2) AC or pulse with overshooting, VP-P must be below the rated voltage. — (3), (4) and (5) When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage.				
		Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage				
		Positional Measurement (Rated voltage) Vo.P 0				
		Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)				
		Positional Measurement (Rated voltage) VP-P VP-P O				
		Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced.				
		The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration.				
		4) Abnormal voltage (surge voltage, static electricity, pulse voltage, etc.) shall exceed the rated voltage.				
		5) When capacitors are used in a series connection, it is necessary to add a balancing circuit such as voltage dividing resistors in order to avoid an imbalance in the voltage applied to each capacitor.				
		2-4. Frequency When the capacitors (Class 2) are used in AC and/or pulse voltages, the capacitors may vibrate themselves and generate audible sound.				

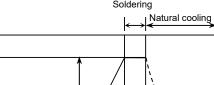
No.	Process		Condition	
3	Designing P.C.board	capacitors. 1) The greater the amount of solder and the more likely that it will be	ations has a direct effect on the reliability of the er, the higher the stress on the chip capacitors, reak. When designing a P.C.board, determine the ends to have proper amount of solder on the	
		Avoid using common solder lan solder land for each termination	d for multiple terminations and provide individual is.	
		3) Size and recommended land di	mensions.	
		Ch	Solder land Solder resist	
		Reflow soldering	(Unit : mm)	
		Case size Symbol	C0402 (CC01005)	
		A	0.15 ~ 0.25	
		В	0.15 ~ 0.25	
		C	0.15 ~ 0.25	

No.	Process			Condition			
3	Designing P.C.board	4)	Recommended chip capacitors layout is as following.				
				Disadvantage against bending stress	Advantage against bending stress		
			Mounting face	Perforation or slit	Perforation or slit		
				Break P.C.board with mounted side up.	Break P.C.board with mounted side down.		
				Mount perpendicularly to perforation or slit	Mount in parallel with perforation or slit		
			Chip arrangement (Direction)	Perforation or slit	Perforation or slit		
			Distance from slit	Closer to slit is higher stress	Away from slit is less stress		
				$(\mathcal{Q}_1 < \mathcal{Q}_2)$	$(\mathcal{Q}_1 < \mathcal{Q}_2)$		

No. **Process** Condition 3 5) Mechanical stress varies according to location of chip capacitors on the P.C.board. Designing P.C.board E Perforation 00000 00000 В Α Stress force A>B>EA>D>ESlit A > CWhen dividing printed wiring boards, the intensities of mechanical stress applied to capacitors are different according to each dividing method in the order of : Push-back < Slit < V-groove < Perforation. Therefore consider not only position of capacitors, but also the way of the dividing the printed wiring boards. 6) Layout recommendation Use of common Use of common Soldering with Example solder land with solder land chassis other SMD Lead wire Chassis Solder land Chip Excessive solder Solder Need to avoid Excessive solder PCB Solder land Solder Missing solder Lead wire Solder resist Solder resist Recommendation Solder resist $Q_2 > Q_1$

No.	Process		Condition					
4	Mounting	 4-1. Stress from mounting head If the mounting head is adjusted too low, it may induce excessive st capacitors to result in cracking. Please take following precautions. Adjust the bottom dead center of the mounting head to reach on the surface and not press it. Adjust the mounting head pressure to be 1 to 3N of static weight. To minimize the impact energy from mounting head, it is important support from the bottom side of the P.C.board. See following examples. 						
		Not recommended Recommended						
		Single-sided mounting	Crack	Support pin is not to be underneath the capacitor.				
		Double-sides mounting	Solder peeling Crack	Support pin				
	echanical impact on the e up dimension of the centering and replacement of it.							

No.	Process	Condition					
5	5 Soldering 5-1. Flux selection Flux can seriously affect the performance of capacitors. Confirm select the appropriate flux.						
		It is recommended to use a mildly activated rosin flux (less than 0.1wt% chlorine). Strong flux is not recommended.					
		2) Excessive flux must be avoided. Please provide proper amount of flux.					
		3) When water-soluble flux is used, enough washing is necessary.					
		5-2. Recommended soldering profile : Reflow method Refer to the following temperature profile at Reflow soldering.					
		Reflow soldering					
	Soldering						



Peak Temp Temp. (°C) 0 Preheating 60-120 sec. Peak Temp time

5-3. Recommended soldering peak temp and peak temp duration for Reflow soldering Pb free solder is recommended, but if Sn-37Pb must be used, refer to below.

Temp./Duration	Reflow soldering			
Solder	Peak temp(°C)	Duration(sec.)		
Lead Free Solder	260 max.	10 max.		
Sn-Pb Solder	230 max.	20 max.		

Recommended solder compositions Lead Free Solder: Sn-3.0Ag-0.5Cu

5-4. Avoiding thermal shock

1) Preheating condition

Soldering	Temp. (°C)
Reflow soldering	ΔT ≦ 150

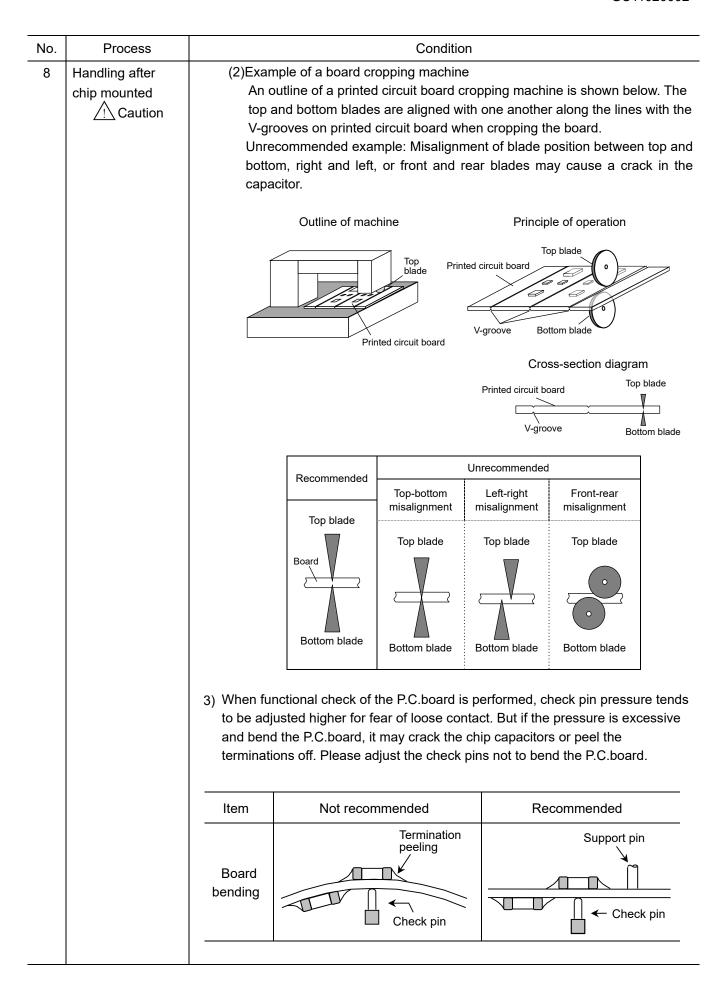
Cooling condition

Natural cooling using air is recommended. If the chips are dipped into a solvent for cleaning, the temperature difference (ΔT) must be less than 100°C.

No.	Process	Condition
5	Soldering	5-5. Amount of solder Excessive solder will induce higher tensile force in chip capacitors when temperature changes and it may result in chip cracking. In sufficient solder may detach the capacitors from the P.C.board.
		Excessive solder Higher tensile force in chip capacitors to cause crack
		Adequate Maximum amount Minimum amount
		Insufficient solder Low robustness may cause contact failure or chip capacitors come off the P.C.board.
	5-7 5-7 7 1 1	5-6. Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder. 5-7. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335C Annex A (Informative), Recommendations to prevent the tombstone phenomenon.)

No.	Process	Condition
6	Cleaning	If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance.
		2) If cleaning condition is not suitable, it may damage the chip capacitors.
		2)-1. Insufficient washing (1) Torminal electrodes may correde by Helegap in the flux
		(1) Terminal electrodes may corrode by Halogen in the flux.
		(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.
		(3) Water soluble flux has higher tendency to have above mentioned problems (1) and (2).
		2)-2. Excessive washing
		When ultrasonic cleaning equipment is used, excessive ultrasonic power or direct vibration transfer to a printed wiring board may generate a resonant vibration in the board. This may cause a crack in a capacitor or its solder joints to the board and degradation in the terminal strength of the capacitor. In order to avoid this, the following cleaning conditions are recommended.
		Power : 20 W/l max.
		Frequency : 40 kHz max. Washing time : 5 minutes max.
		2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may bring the same result as insufficient cleaning.
7	Coating and molding of the P.C.board	 When the P.C.board is coated, please verify the quality influence on the product. Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors. Please verify the curing temperature.
		5, 7.2222 .3mg tang tampatatan

No.	Process	Condition				
8	Handling after chip mounted Caution	Please pay attention not to bend or distort the P.C.board after soldering in handling otherwise the chip capacitors may crack. Bend Twist				
		proper tooling. Printed cropping jig as shown prevent inducing mec (1)Example of a boan Recommended exclose to the cropping the capacitor is countrecommended of the pushing directi	d circuit board cropping should circuit board cropping should not the following figure or a hanical stress on the board. It cropping jig sample: The board should being jig so that the board is not impressive.	d out by hand, but by using the ld be carried out using a board a board cropping apparatus to e pushed from the back side, a bent and the stress applied to is far from the cropping jig and the board, large tensile stress is ks.		
	Unrecommended					
		Printed circuit board V-groove Board Slot Slot Slot	Printed circuit board Components Load point V-groove Slot	Load point Printed circuit board V-groove		



No.	Process	Condition
9	Handling of loose chip capacitors	If dropped the chip capacitors may crack. Once dropped do not use it. Especially, the large case sized chip capacitors are tendency to have cracks easily, so please handle with care. Crack Floor
	Piling the P.C.board after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitors of another board to cause crack. Crack Crack	
10	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
11	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335C Annex F (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient: 3 multiplication rule, Temperature acceleration coefficient: 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.

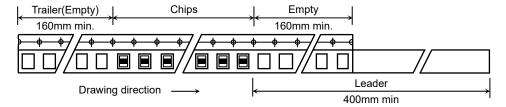
No.	Process	Condition				
12	Caution during operation of equipment	 A capacitor shall not be touched directly with bare hands during operation in order to avoid electric shock. Electric energy held by the capacitor may be discharged through the human body when touched with a bare hand. Even when the equipment is off, a capacitor may stay charged. The capacitor should be handled after being completely discharged using a resistor. 				
		2) The terminals of a capacitor shall not be short-circuited by any accidental contact with a conductive object. A capacitor shall not be exposed to a conductive liquid such as an acid or alkali solution. A conductive object or liquid, such as acid and alkali, between the terminals may lead to the breakdown of a capacitor due to short circuit.				
		 Confirm that the environment to which the equipment will be exposed during transportation and operation meets the specified conditions. Do not to use the equipment in the following environments. Environment where a capacitor is spattered with water or oil Environment where a capacitor is exposed to direct sunlight Environment where a capacitor is exposed to Ozone, ultraviolet rays or radiation Environment where a capacitor exposed to corrosive gas(e.g. hydrogen sulfide, sulfur dioxide, chlorine. ammonia gas etc.) Environment where a capacitor exposed to vibration or mechanical shock exceeding the specified limits. Atmosphere change with causes condensation 				
13	Others Caution	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us. (1) Aerospace/Aviation equipment (cars, electric trains, ships, etc.) (3) Medical equipment (Excepting Pharmaceutical Affairs Law classification Class 1, 2)				
		 (3) Medical equipment (Excepting Pharmaceutical Affairs Law classification Class1, 2) (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment (12) Safety equipment (13) Other applications that are not considered general-purpose applications When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment. 				

11. TAPE PACKAGING SPECIFICATION

1. CONSTRUCTION AND DIMENSION OF TAPING

1-1. Dimensions of carrier tape Dimensions of paper tape shall be according to Appendix 3.

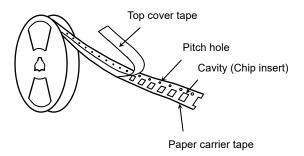
1-2. Bulk part and leader of taping



1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 4.

1-4. Structure of taping

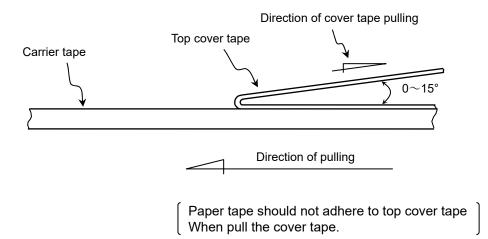


2. CHIP QUANTITY

Please refer to detail page on TDK web.

3. PERFORMANCE SPECIFICATIONS

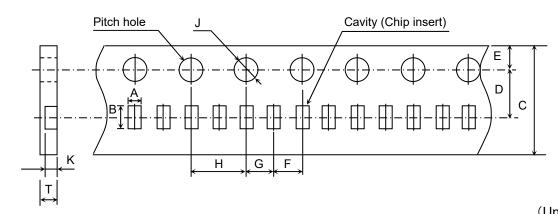
3-1. Fixing peeling strength (top tape) 0.05-0.7N. (See the following figure.)



- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. When get cover tape off, there shall not be difficulties by unfitting clearance, burrs and crushes of cavities, also the sprocket holes shall not be covered by absorbing dust into the suction nozzle.

Appendix 3

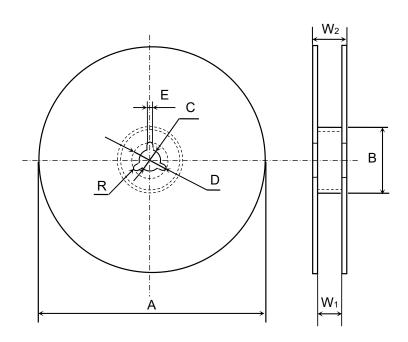
Paper Tape



<u></u>						(Unit:mm)
Symbol	Α	В	С	D	Е	F
Dimension	(0.25)	(0.45)	8.00±0.30	3.50±0.05	1.75±0.10	2.00±0.05
Symbol	G	Н	J	К	Т	
Dimension	2.00±0.05	4.00±0.05	ø1.50 +0.10	0.23±0.02	0.29 min.	•

) Reference value.

Appendix 4
Dimensions of reel (Material : Polystyrene)



(Unit:mm)

Symbol	А	В	С	D	Е	W1
Dimension	ø178±2.0	Ø60±2.0	ø13±0.5	ø21±0.8	2.0±0.5	9.0±0.3

Symbol	W2	R
Dimension	13.0±1.4	1.0